PJD12P03L

30V P-Channel Enhancement Mode MOSFET

FEATURES

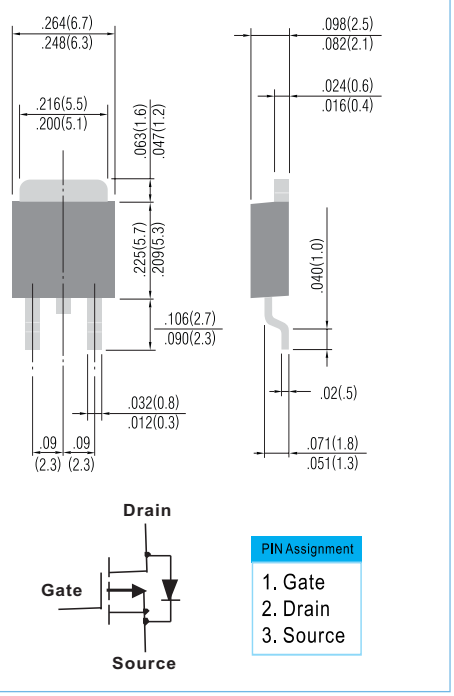
- $R_{DS(ON)}$, V_{GS}@ -10V,I_{DS}@ -8.0A=28mΩ
- $R_{DS(ON)}$, V_{GS}@ -4.5V,I_{DS}@ -5.0A=36mΩ

- Advanced Trench Process Technology
- High Density Cell Design For Ultra Low On-Resistance
- Specially Designed for DC/DC Converters
- Fully Characterized Avalanche Voltage and Current
- Pb free product : 99% Sn above can meet RoHS environment substance directive request

MECHANICALDATA

- Case: TO-252 Molded Plastic
- Terminals : Solderable per MIL-STD-750D,Method 1036.3
- Marking : 12P03L

DPAK / TO-252 Unit: inch (mm)



Maximum RATINGS and Thermal Characteristics (T_A=25°C unless otherwise noted)

PARAMETER	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current	I_D	-12	A
Pulsed Drain Current [1]	I_{DM}	-55	A
Maximum Power Dissipation T_A=25°C T_A=75°C	P_D	38 22	W
Operating Junction and Storage Temperature Range	T_J,T_{STG}	-55 to + 150	°C
Avalanche Energy with Single Pulse ID=23A, VDD=25V, L=0.5mH	E_{AS}	130	mJ
Junction-to-Case Thermal Resistance	$R_{\theta JC}$	3.3	°C/W
Junction-to Ambient Thermal Resistance(PCB mounted)[2]	$R_{\theta JA}$	50	°C/W

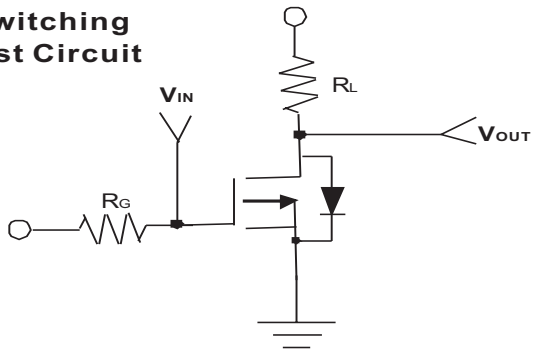
Note: 1. Maximum DC current limited by the package
2. Surface mounted on FR4 board, t ≤ 10 sec

PJD12P03L

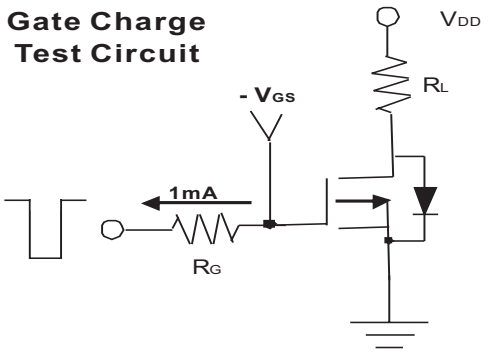
ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Units
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}=0V, I_D=-250uA	-30	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=-250uA	-1	-	-3	V
Drain-Source On-State Resistance	$R_{DS(on)}$	V_{GS}=-4.5V, I_D=-5.0A	-	28	36	mΩ
Drain-Source On-State Resistance	$R_{DS(on)}$	V_{GS}=-10V, I_D=-8.0A	-	21	28	mΩ
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=-30V, V_{GS}=0V	-	-	-1	uA
Gate Body Leakage	I_{GSS}	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
Forward Transconductance	g_{fs}	V_{DS}=-10V, I_D=-15A	15	-	-	S
Dynamic						
Total Gate Charge	Q_g	V_{DS}=-15V,I_D=-8.0A,V_{GS}=-5V	-	14.2	-	nC
		V_{DS}=-15V, I_D=-8.0A V_{GS}=-10V	-	26.8	-	
Gate-Source Charge	Q_{gs}		-	3.8	-	
Gate-Drain Charge	Q_{gd}		-	4.8	-	
Turn-On Delay Time	$T_{d(on)}$	V_{DD}=-15V , R_L=15Ω I_D=-1A , V_{GEN}=-10V R_G=3.6Ω	-	11.5	15	ns
Turn-On Rise Time	t_{rr}		-	6.2	8.5	
Turn-Off Delay Time	$t_{d(off)}$		-	68.7	80	
Turn-Off Fall Time	t_f		-	25.6	32	
Input Capacitance	C_{iss}	V_{DS}=-15V, V_{GS}=0V f=1.0MH_Z	-	1550	-	pF
Output Capacitance	C_{oss}		-	300	-	
Reverse Transfer Capacitance	C_{rss}		-	155	-	
Source-Drain Diode						
Max. Diode Forward Current	I_s	-	-	-	-30	A
Diode Forward Voltage	V_{SD}	I_S=-8.0A , V_{GS}=0V	-	-0.81	-1.2	V

Switching Test Circuit



Gate Charge Test Circuit



PJD12P03L

Typical Characteristics Curves (T_A=25°C, unless otherwise noted)

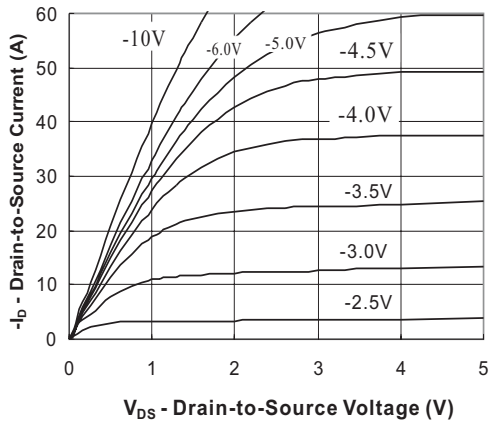


FIG.1- Output Characteristic

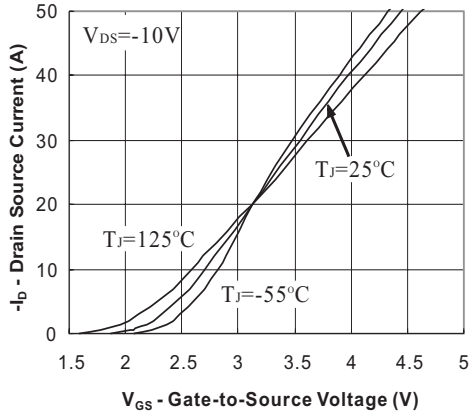


FIG.2- Transfer Characteristic

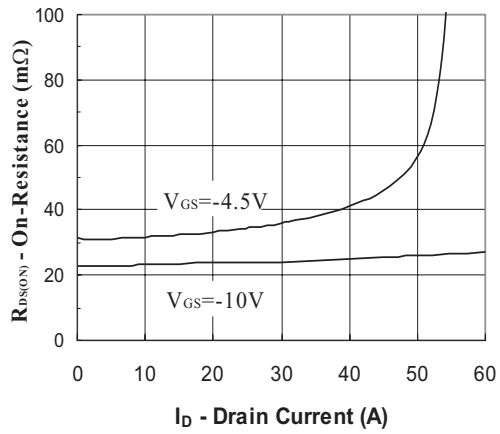


FIG.3- On Resistance vs Drain Current

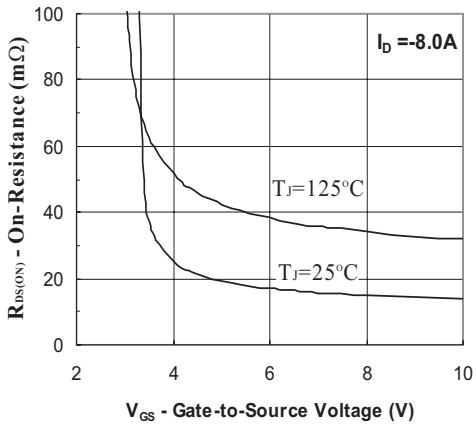


FIG.4- On Resistance vs Gate to Source Voltage

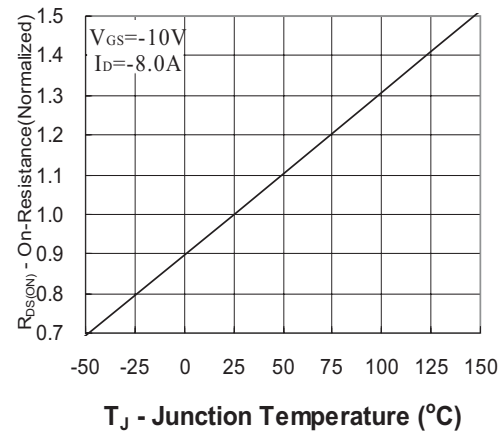


FIG.5- On Resistance vs Junction Temperature

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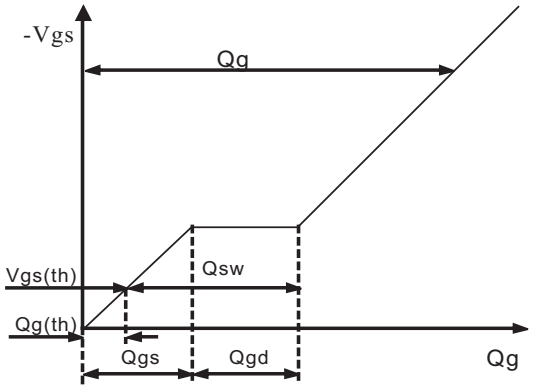

Fig.6 - Gate Charge Waveform

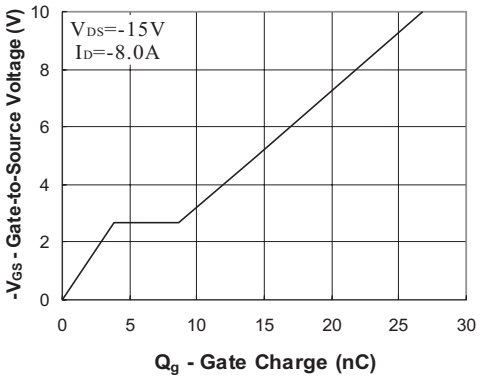

Fig.7 - Gate Charge

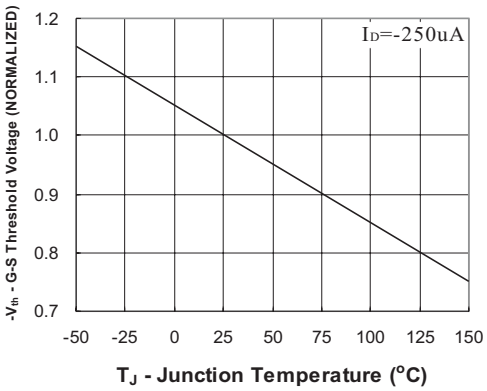

Fig.8 - Threshold Voltage vs Temperature

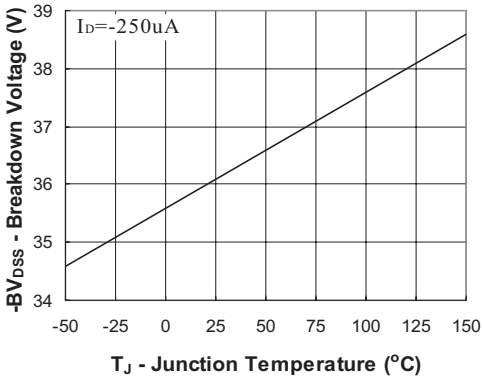

Fig.9 - Breakdown Voltage vs Junction Temperature

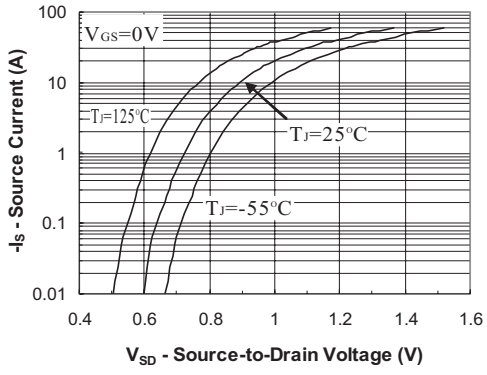

Fig.10 - Source-Drain Diode Forward Voltage